



ISSN No. : 2321-9653

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**International Journal for Research in Applied
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IJRASET is indexed with Crossref for DOI-DOI : 10.22214

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by

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Volume 10, Issue VII, July 2022

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Detecting Abnormal Activities in ATM Centres

by

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after review is found suitable and has been published in

Volume 10, Issue VII, July 2022

in

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It is here by certified that the paper ID : IJRASET45200, entitled

Detecting Abnormal Activities in ATM Centres

by

Shreejith K B

after review is found suitable and has been published in

Volume 10, Issue VII, July 2022

in

*International Journal for Research in Applied Science &
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